

The RF Line

NPN SILICON RF POWER TRANSISTOR

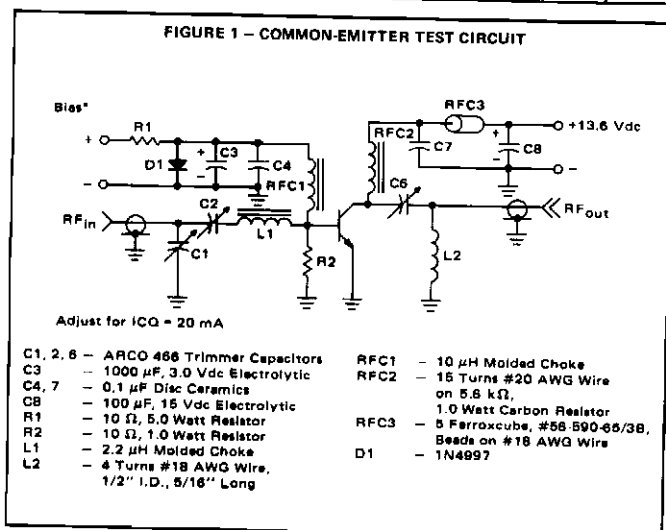
... designed primarily for use in single sideband linear amplifier output applications in citizens band and other communications equipment operating to 30 MHz.

- Characterized for Single Sideband and Large-Signal Amplifier Applications Utilizing Low-Level Modulation
- Specified 13.6 V, 30 MHz Characteristics —
 - Output Power = 12 W (PEP)
 - Minimum Efficiency = 40% (SSB)
 - Output Power = 12 W (CW)
 - Minimum Efficiency = 50% (CW)
 - Minimum Power Gain = 10 dB (PEP & CW)
- Common Collector Configuration

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CE0}	18	Vdc
Collector-Base Voltage	V_{CB0}	48	Vdc
Emitter-Base Voltage	V_{EB0}	4.0	Vdc
Collector Current — Continuous	I_C	4.0	Ade
Total Device Dissipation @ $T_C = 60^\circ\text{C}$ Derate above 60°C	P_D	10 0.1	Watts W/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +150	$^\circ\text{C}$

FIGURE 1 — COMMON-EMITTER TEST CIRCUIT

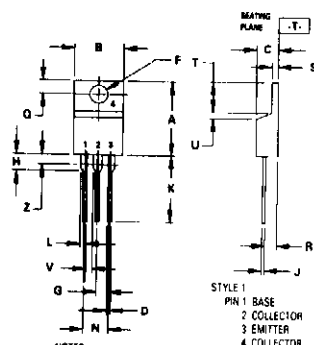
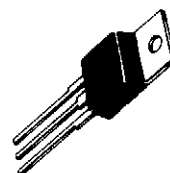


MRF475

12 W (PEP) — 12 W (CW) — 30 MHz

RF POWER TRANSISTOR

NPN SILICON



- NOTES
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
 2. CONTROLLING DIMENSION: INCH
 3. DIM Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED

DIM	MIN	MAX	MIN	MAX
A	14.48	15.75	0.570	0.620
B	9.98	10.29	0.390	0.405
C	4.92	4.82	0.190	0.190
D	0.54	0.86	0.025	0.035
E	3.91	3.73	0.142	0.147
F	2.42	2.66	0.095	0.105
G	2.80	3.93	0.110	0.155
H	0.36	0.56	0.014	0.022
I	12.70	14.27	0.500	0.562
J	1.15	1.29	0.045	0.050
K	4.83	5.32	0.190	0.210
L	2.54	3.94	0.100	0.150
M	2.04	2.75	0.080	0.110
N	1.12	1.39	0.045	0.055
O	5.97	8.47	0.235	0.335
P	0.00	1.27	0.000	0.050
Q	1.15	—	0.045	—
R	—	2.04	—	0.080

CASE 221A-04
 TO-220AB

MRF475

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage ($I_C = 20\text{ mA}$, $I_E = 0$)	$V_{(BR)CEO}$	18	—	—	Vdc
Collector-Emitter Breakdown Voltage ($I_C = 50\text{ mA}$, $V_{BE} = 0$)	$V_{(BR)CES}$	48	—	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 5.0\text{ mA}$, $I_C = 0$)	$V_{(BR)EB0}$	4.0	—	—	Vdc
Collector Cutoff Current ($V_{CB} = 25\text{ Vdc}$, $I_E = 0$)	I_{CBO}	—	—	1.0	mA
ON CHARACTERISTICS					
DC Current Gain ($I_C = 500\text{ mA}$, $V_{CE} = 5.0\text{ Vdc}$)	h_{FE}	30	60	—	—
DYNAMIC CHARACTERISTICS					
Output Capacitance ($V_{CB} = 13.6\text{ Vdc}$, $I_E = 0$, $f = 1.0\text{ MHz}$)	C_{ob}	—	125	145	pF
FUNCTIONAL TESTS (SSB)					
Common-Emitter Amplifier Power Gain ($V_{CC} = 13.6\text{ Vdc}$, $P_{out} = 12\text{ W (PEP)}$, $f_1 = 30\text{ MHz}$, $f_2 = 30.001\text{ MHz}$, $I_{CQ} = 20\text{ mA}$)	G_{PE}	10	12	—	dB
Collector Efficiency ($V_{CC} = 13.6\text{ Vdc}$, $P_{out} = 12\text{ W (PEP)}$, $f_1 = 30\text{ MHz}$, $f_2 = 30.001\text{ MHz}$, $I_{CQ} = 20\text{ mA}$)	η	40	—	—	%
Intermodulation Distortion (1) ($V_{CC} = 13.6\text{ Vdc}$, $P_{out} = 12\text{ W (PEP)}$, $f_1 = 30\text{ MHz}$, $f_2 = 30.001\text{ MHz}$, $I_{CQ} = 20\text{ mA}$)	IMD	—	—	-30	dB
FUNCTIONAL TESTS (CW)					
Common-Emitter Amplifier Power Gain ($V_{CC} = 13.6\text{ Vdc}$, $P_{out} = 4.0\text{ W}$, $f = 30\text{ MHz}$)	G_{PE}	10	12	—	dB
Collector Efficiency ($V_{CC} = 13.6\text{ Vdc}$, $P_{out} = 4.0\text{ W}$, $f = 30\text{ MHz}$)	η	50	—	—	%
Percentage Up-Modulation (1) (4.0 W Carrier)	—	—	100	—	%
IMPEDANCE CHARACTERISTICS					
Series Equivalent Input	Z_{in}	—	4.5-j2.4	—	Ohms
Series Equivalent Output	Z_{out}	—	5.1-j3.2	—	Ohms
Parallel Equivalent Input	Z_{in}	—	5.8/10.9	—	Ω/pF
Parallel Equivalent Output	Z_{out}	—	7.1/11.3	—	Ω/pF

(1) To proposed EIA method of measurement. Reference peak envelope power.

(2) Percentage Up-Modulation is measured in the test circuit (Figure 1) by setting the Carrier Power (P_C) to 4.0 Watts with $V_{CC} = 13.6\text{ Vdc}$ and noting the power input. Then the Peak Envelope Power (PEP) is noted after doubling the original power input to simulate driver modulation.

$$\text{Percentage Up-Modulation} = \left[\left(\frac{PEP}{P_C} \right) - 1 \right] \times 100$$

FIGURE 2 – OUTPUT POWER versus INPUT POWER

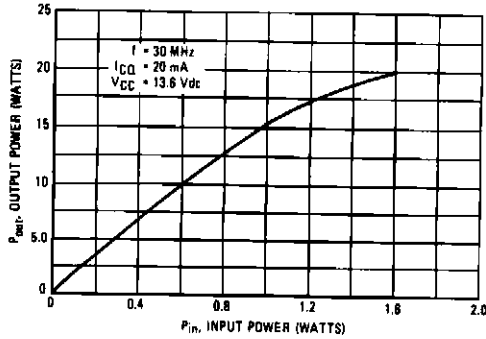


FIGURE 3 – INTERMODULATION DISTORTION versus OUTPUT POWER

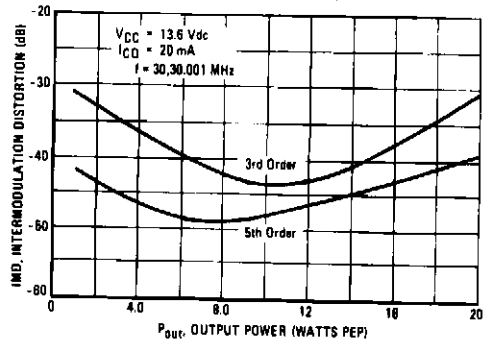


FIGURE 4 – OUTPUT POWER versus SUPPLY VOLTAGE

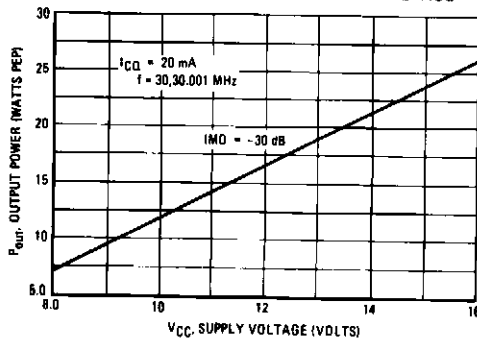


FIGURE 5 – OUTPUT CAPACITANCE versus FREQUENCY

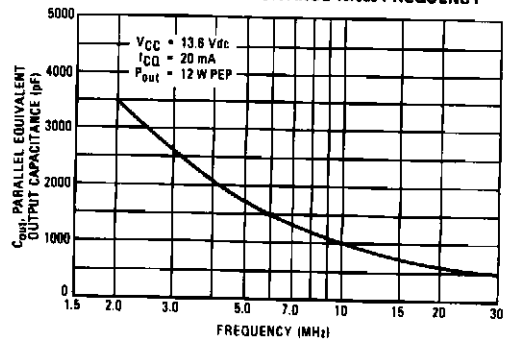


FIGURE 6 – OUTPUT RESISTANCE versus FREQUENCY

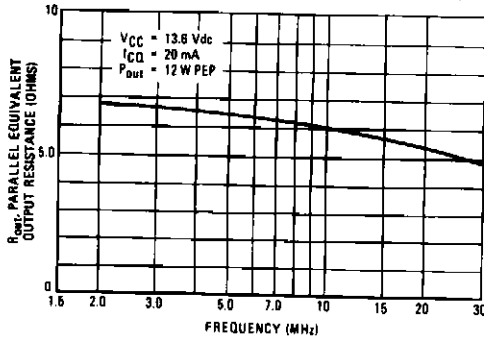


FIGURE 7 – POWER GAIN versus FREQUENCY

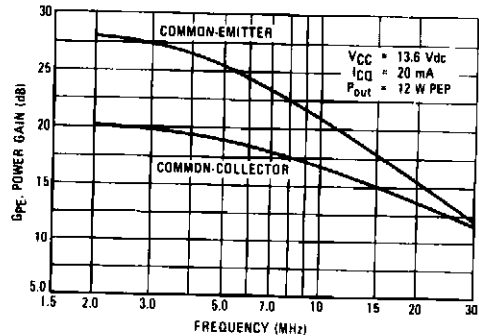


FIGURE 8 - SERIES EQUIVALENT INPUT IMPEDANCE

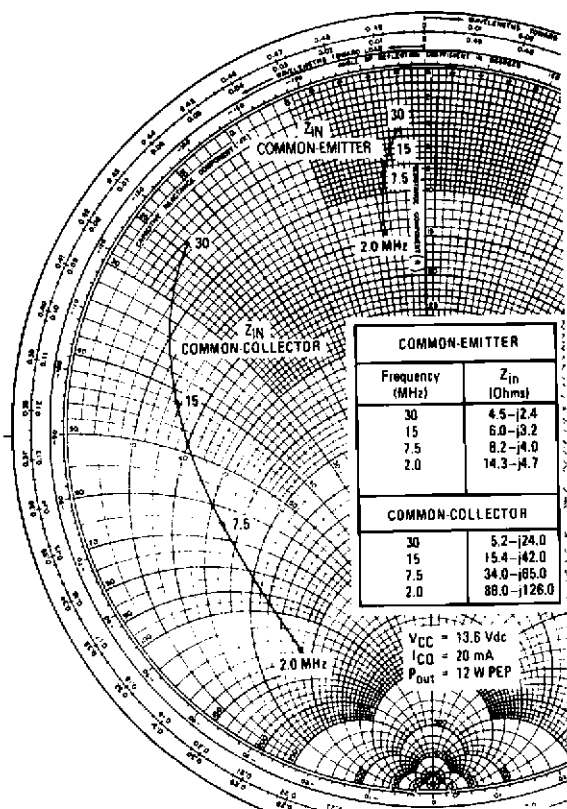
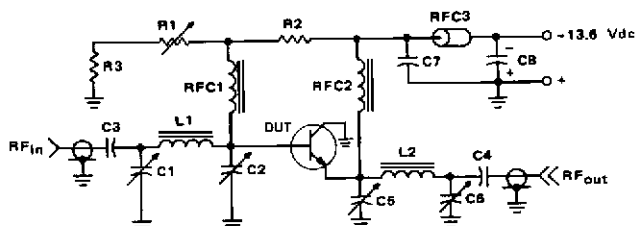


FIGURE 9 - COMMON-COLLECTOR TEST CIRCUIT



- C1, 5 - ARCO 466 Trimmer Capacitors
- C2 - ARCO 463 Trimmer Capacitor
- C3, 4, 7 - 0.1 μF Ceramic Disc
- C6 - ARCO 469 Trimmer Capacitor
- C8 - 100 μF 15 Vdc Electrolytic
- R1 - 250 Ω , 2.0 W Resistor
- R2 - 5.1 Ω , 1/2 W Resistor
- R3 - 51 Ω , 2.0 W Resistor

- L1 - 0.33 μH Molded Choke
- L2 - 4 Turns #18 AWG Wire, 1/8" I.D., 5/16" Long
- RFC1 - 18 μH Molded Choke
- RFC2 - 15 Turns #20 AWG Wire on 100 Ω , 1.0 W Carbon Resistor
- RFC3 - Ferroxcube, #56-590-65/38, Beads on #18 AWG Wire